

STD5NK52ZD, STB5NK52ZD-1 STF5NK52ZD, STP5NK52ZD

N-channel 520 V,1.22 Ω,4.4 A,TO-220,IPAK,I²PAK,DPAK,TO-220FP Zener-protected SuperMESH™ Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)} max	I _D	Pw
STB5NK52ZD-1	520 V	< 1.5 Ω	4.4 A	70 W
STD5NK52ZD-1	520 V	< 1.5 Ω	4.4 A	70 W
STD5NK52ZD	520 V	< 1.5 Ω	4.4 A	70 W
STF5NK52ZD	520 V	< 1.5 Ω	4.4 A	25 W
STP5NK52ZD	520 V	< 1.5 Ω	4.4 A	70 W

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability
- Improved ESD capability

Application

Switching applications

Description

The SuperFREDMesh™ series associates all advantages of reduced on-resistance, zener gate protection and very high dv/dt capability with a fast body-drain recovery diode. Such series complements the "FDmesh™" advanced technology.

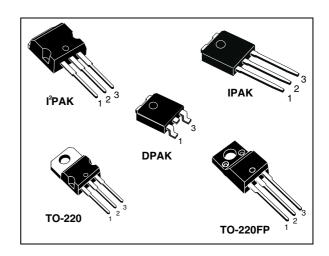


Figure 1. Internal schematic diagram

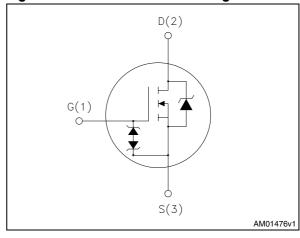


Table 1. Device summary

Order codes	Marking	Package	Packaging
STB5NK52ZD-1	B5NK52ZD	I ² PAK	Tube
STD5NK52ZD-1	D5NK52ZD	IPAK	Tube
STD5NK52ZD	D5NK52ZD	DPAK	Tape and reel
STF5NK52ZD	F5NK52ZD	TO-220FP	Tube
STP5NK52ZD	P5NK52ZD	TO-220	Tube

Contents

1	Electrical ratings	3
2	Electrical characteristics	
3	Test circuits	9
4	Package mechanical data	10
5	Packaging mechanical data	15
6	Revision history	16

1 Electrical ratings

Table 2. Absolute maximum ratings

			Value				
Symbol	Parameter	TO-220 I ² PAK	IPAK DPAK	TO-220FP	Unit		
V _{DS}	Drain-source voltage (V _{GS} = 0)		520		V		
V_{GS}	Gate- source voltage	± 30			٧		
I _D	Drain current (continuous) at $T_C = 25$ °C	4.4		4.4		4.4 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	2.7		2.7 ⁽¹⁾	Α		
I _{DM} ⁽²⁾	Drain current (pulsed)	17.6	3	17.6 ⁽¹⁾	Α		
P _{TOT}	Total dissipation at $T_C = 25$ °C	70		25	W		
	Derating factor	0.56	3	0.2	W/°C		
V _{ESD(G-S)}	Gate source ESD(HBM-C=100pF, R=1.5 kΩ)	2800		V			
dv/dt (3)	Peak diode recovery voltage slope	15		V/ns			
T _j T _{stg}	Operating junction temperature Storage temperature		-55 to 150)	°C		

- 1. Limited only by max temperature allowed
- 2. Pulse width limited by safe operating area
- 3. $I_{SD} \leq$ 4.4 A, di/dt \leq 200 A/ μ s, V_{DD} = 80% $V_{(BR)DSS}$

Table 3. Thermal data

Symbol	Parameter	TO-220 I ² PAK	IPAK DPAK	TO-220FP	Unit	
Rthj-case	Thermal resistance junction-case max	1.7	8	5	°C/W	
Rthj-amb	Thermal resistance junction-ambient max	62.5	100	62.5	°C/W	
T _I	Maximum lead temperature for soldering purpose	300			°C	

Table 4. Avalanche characteristics

Symbol	Parameter	Max value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	4.4	Α
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	170	mJ

2 Electrical characteristics

(Tcase =25°C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	520			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating V_{DS} = Max rating, T_{C} =125 °C			1 50	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			± 10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 50 \mu A$	2.5	3.75	4.5	V
R _{DS(on}	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 2.2 \text{ A}$		1.22	1.5	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs}	Forward transconductance	$V_{DS} = 15 \text{ V}, I_D = 2.2 \text{ A}$		3.1		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz, V}_{GS} = 0$		529 71 13.4		pF pF pF
C _{OSS eq} ⁽¹⁾	Equivalent output capacitance	V _{GS} = 0, V _{DS} = 0 to 416 V		11		pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 416 \text{ V}, I_{D} = 4.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see <i>Figure 19</i>)		16.9 4.2 8.4		nC nC nC

^{1.} $C_{oss\ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_DS increases from 0 to 80% V_{DSS}

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
$\begin{array}{c} t_{\rm d(on)} \\ t_{\rm r} \\ t_{\rm d(off)} \\ t_{\rm f} \end{array}$	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 260 \text{ V}, I_{D} = 2.2 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 18</i>)		11.4 13.6 23.1 15		ns ns ns ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current				4.4	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				17.6	Α
V _{SD} (2)	Forward on voltage	$I_{SD} = 4.4 \text{ A}, V_{GS} = 0$			1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 4.4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		97.7		ns
Q_{rr}	Reverse recovery charge	V _{DD} = 60 V		300		nC
I _{RRM}	Reverse recovery current	(see Figure 23)		5.9		Α
t _{rr}	Reverse recovery time	$I_{SD} = 4.4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		139		ns
Q_{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C		500		nC
I _{RRM}	Reverse recovery current	(see Figure 23)		7.2		Α

^{1.} Pulse width limited by safe operating area

Table 9. Gate-source Zener diode

Syı	mbol	Parameter	Test conditions	Min	Тур	Max	Unit
BVo	GSO ⁽¹⁾	Gate-source breakdown voltage	Igs=± 1 mA (open drain)	30			٧

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components

^{2.} Pulsed: Pulse duration = $300 \mu s$, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220 / Figure 3. Thermal impedance for TO-220 / I²PAK

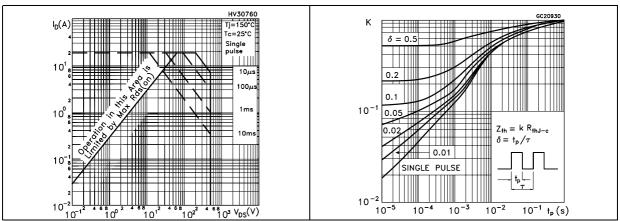


Figure 4. Safe operating area for TO-220FP Figure 5. Thermal impedance for TO-220FP

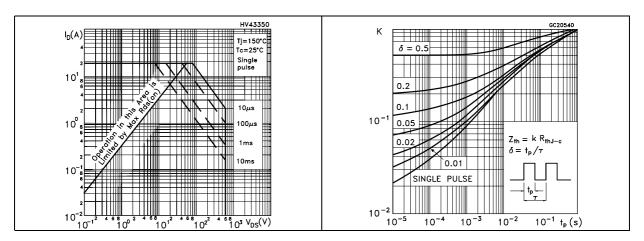


Figure 6. Safe operating area for IPAK/DPAK Figure 7. Thermal impedance for IPAK/DPAK

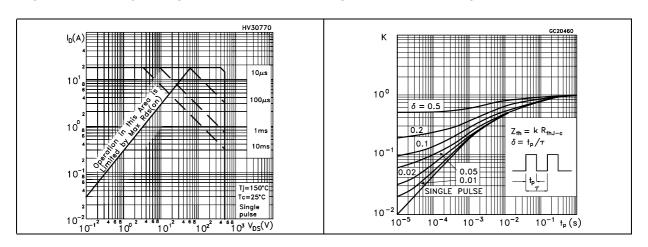
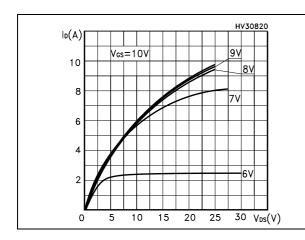


Figure 8. Output characteristics

Figure 9. Transfer characteristics



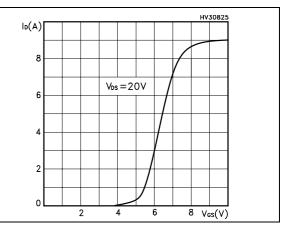
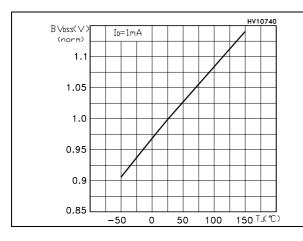


Figure 10. Normalized \mathbf{B}_{VDSS} vs temperature

Figure 11. Static drain-source on resistance



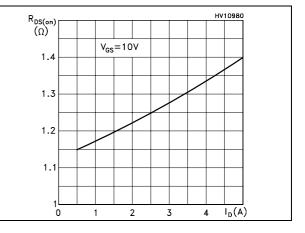
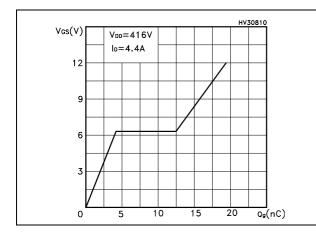


Figure 12. Gate charge vs gate-source voltage Figure 13. Capacitance variations



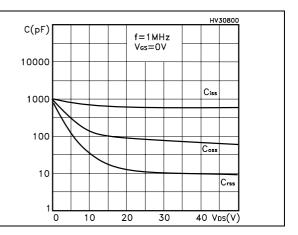
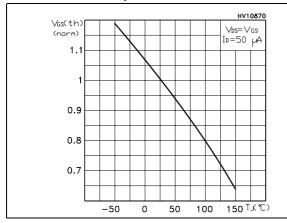


Figure 14. Normalized gate threshold voltage I vs temperature

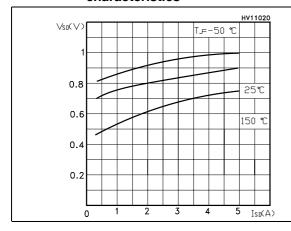
Figure 15. Normalized on resistance vs temperature

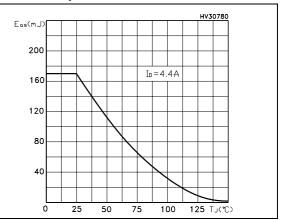


R_{DS}(On)
(norm)
2.5
2.0
1.5
1.0
0.5
0
-50
0
50
100
150 T.(*C)

Figure 16. Source-drain diode forward characteristics

Figure 17. Maximum avalanche energy vs temperature





3 Test circuits

Figure 18. Switching times test circuit for resistive load

Figure 19. Gate charge test circuit

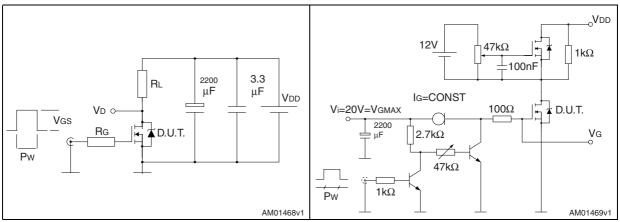


Figure 20. Test circuit for inductive load switching and diode recovery times

Figure 21. Unclamped Inductive load test circuit

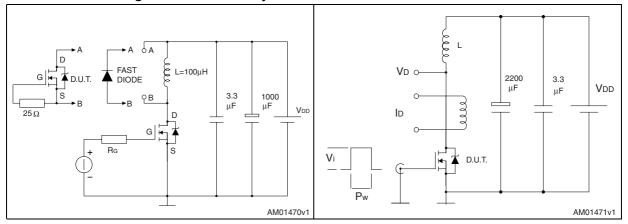
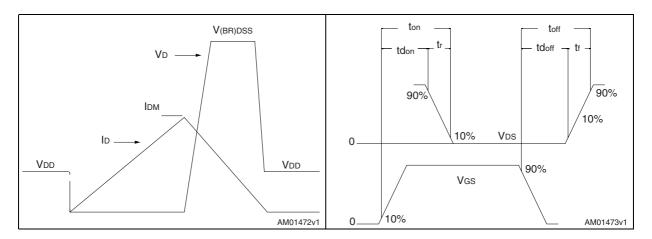


Figure 22. Unclamped inductive waveform

Figure 23. Switching time waveform

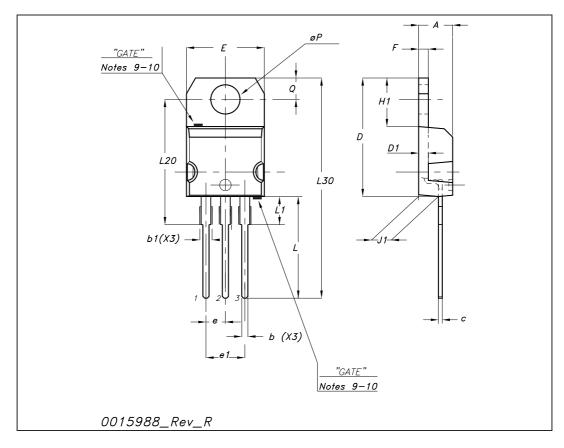


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

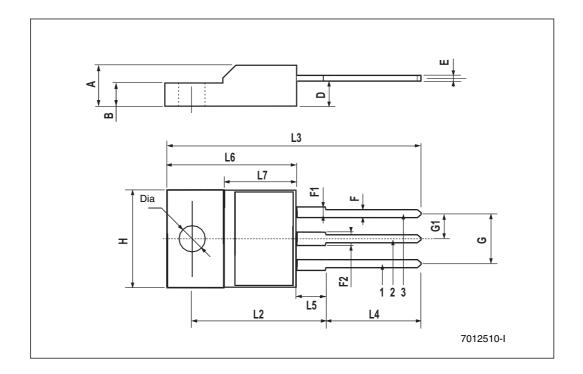
TO-2	220	mec	hani	cal	data

Dim	mm			inch		
	Min	Тур	Max	Min	Тур	Max
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
С	0.48		0.70	0.019		0.027
D	15.25		15.75	0.6		0.62
D1		1.27			0.050	
E	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.051
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
ØP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



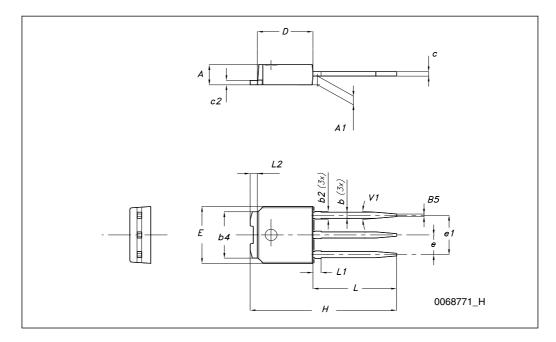
TO-220FP mechanical data

Dim.	mm.			inch		
	Min.	Тур	Max.	Min.	Тур.	Max.
Α	4.40		4.60	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.70	0.017		0.027
F	0.75		1.00	0.030		0.039
F1	1.15		1.50	0.045		0.067
F2	1.15		1.50	0.045		0.067
G	4.95		5.20	0.195		0.204
G1	2.40		2.70	0.094		0.106
Н	10		10.40	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.80		10.60	0.385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.90		16.40	0.626		0.645
L7	9		9.30	0.354		0.366
Dia	3		3.2	0.118		0.126



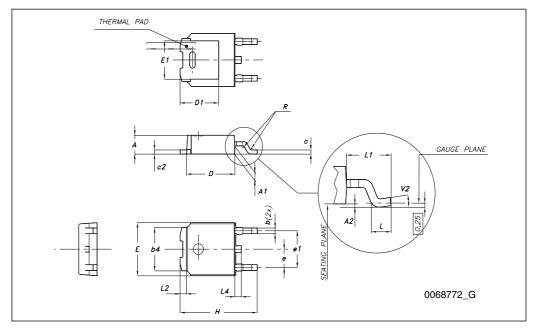
TO-251	(IPAK)	mechanical	data
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DIM	mm.			
	min.	typ	max.	
Α	2.20		2.40	
A1	0.90		1.10	
b	0.64		0.90	
b2			0.95	
b4	5.20		5.40	
С	0.45		0.60	
c2	0.48		0.60	
D	6.00		6.20	
E	6.40		6.60	
е		2.28		
e1	4.40		4.60	
Н		16.10		
L	9.00		9.40	
(L1)	0.80		1.20	
L2		0.80		
V1		10 °		



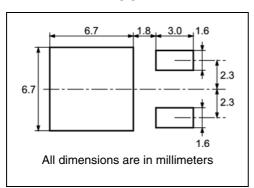
TO-252 (DPAK) mechanical data

DIM.	mm.				
	min.	typ	max.		
Α	2.20		2.40		
A1	0.90		1.10		
A2	0.03		0.23		
b	0.64		0.90		
b4	5.20		5.40		
С	0.45		0.60		
c2	0.48		0.60		
D	6.00		6.20		
D1		5.10			
E	6.40		6.60		
E1		4.70			
е		2.28			
e1	4.40		4.60		
Н	9.35		10.10		
L	1				
L1		2.80			
L2		0.80			
L4	0.60		1		
R		0.20			
V2	0 °		8 °		

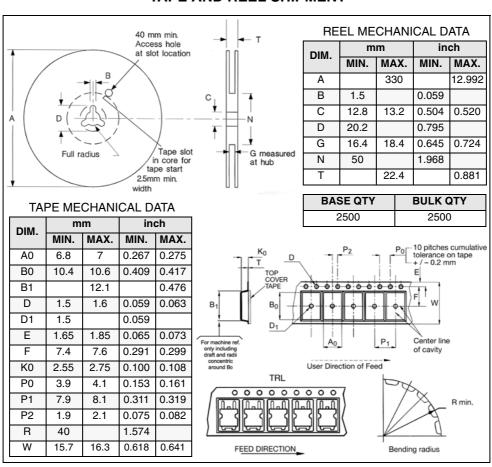


5 Packaging mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



6 Revision history

Table 10. Document revision history

Date	Revision	Changes
16-Jun-2005	1	First release
06-Sep-2005	2	Inserted ecopack indication
03-Oct-2005	3	Corrected value on Table 2
23-Mar-2006	4	Complete version. New template
15-Sep-2008	5	Inserted new package: TO-220FP

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